

P-Channel Enhancement Mode MOSFET

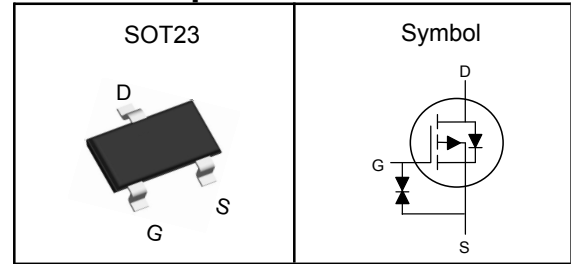
Features

- Low Rdson for low conduction loss
- Reliable and Rugged
- ROHS Compliant & Halogen-Free

Applications

- Power Management in Desktop Computer
- DC/DC Converters

Pin Description



V _{DSS}	-20	V
R _{DS(ON)-Typ}	39	mΩ
I _D	-4.0	A

Absolute Maximum Ratings (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter	P-Channel	Unit
V _{DSS}	Drain-Source Voltage	-20	V
V _{GSS}	Gate-Source Voltage	±8	V
T _J	Maximum Junction Temperature	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
I _{DM} ^①	Pulse Drain Current Tested	-30	A
I _D	Continuous Drain Current	-4.0	A
P _D	Maximum Power Dissipation	1.5	W

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R _{θJA} ^③	Thermal Resistance-Junction to Ambient (Max)	100	°C/W

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C.

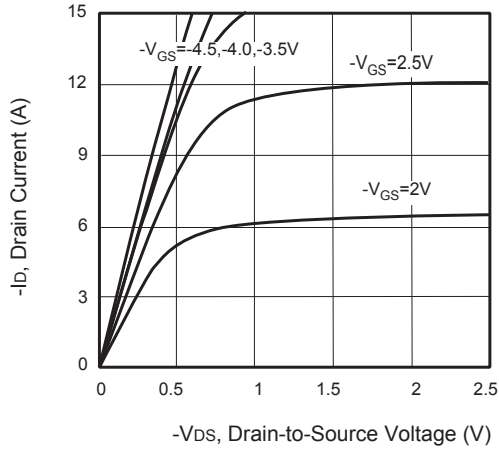
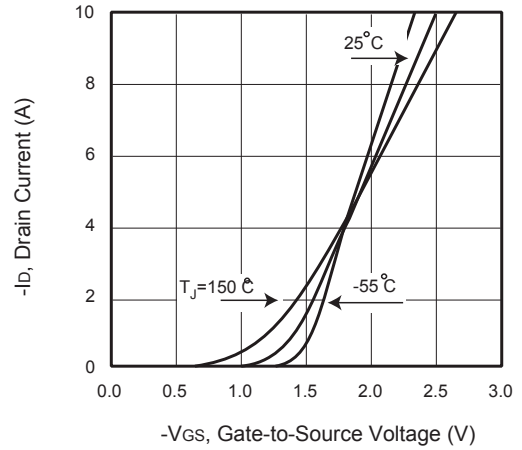
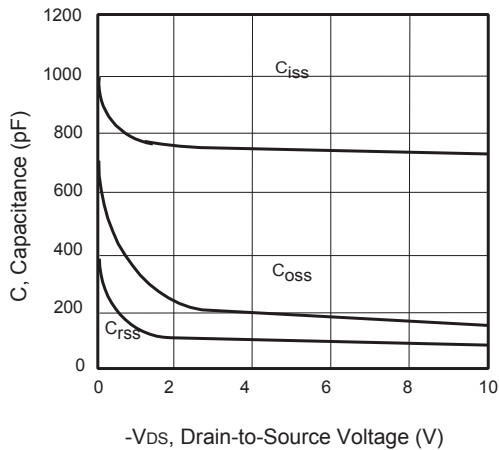
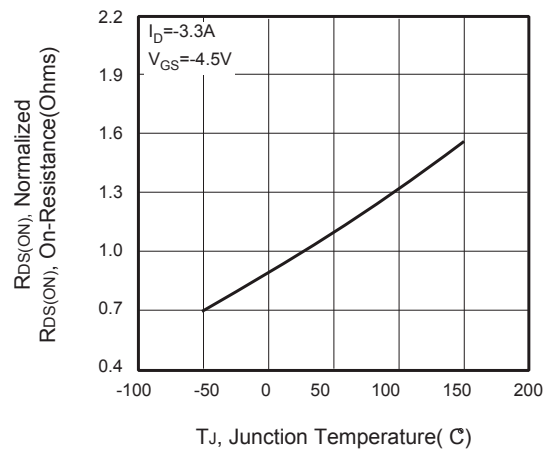
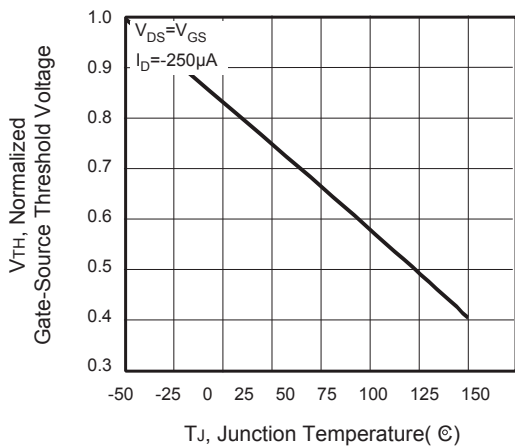
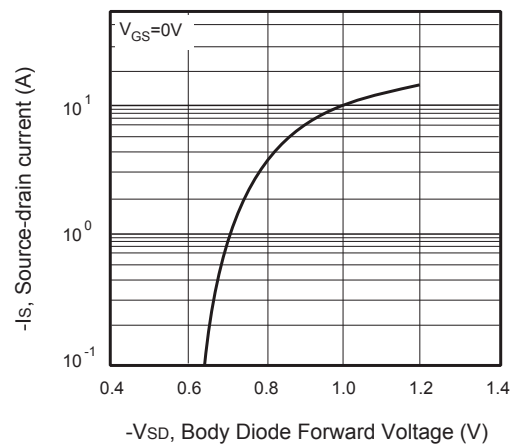
Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

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Electrical Characteristics ($T_J=25^\circ\text{C}$, Unless Otherwise Noted)

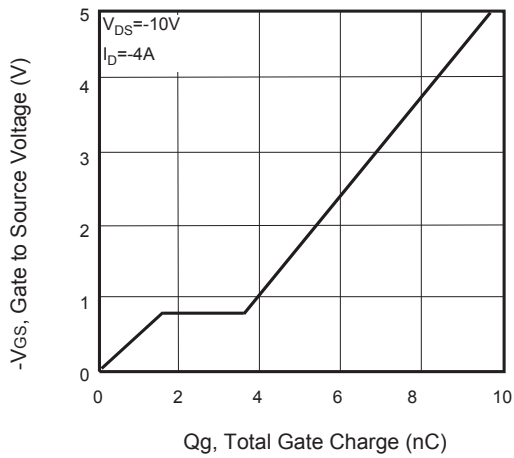
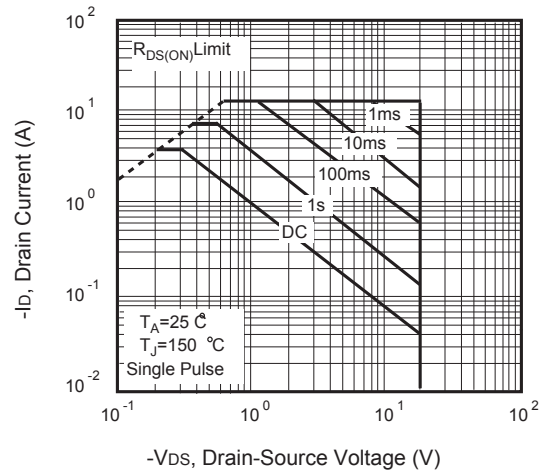
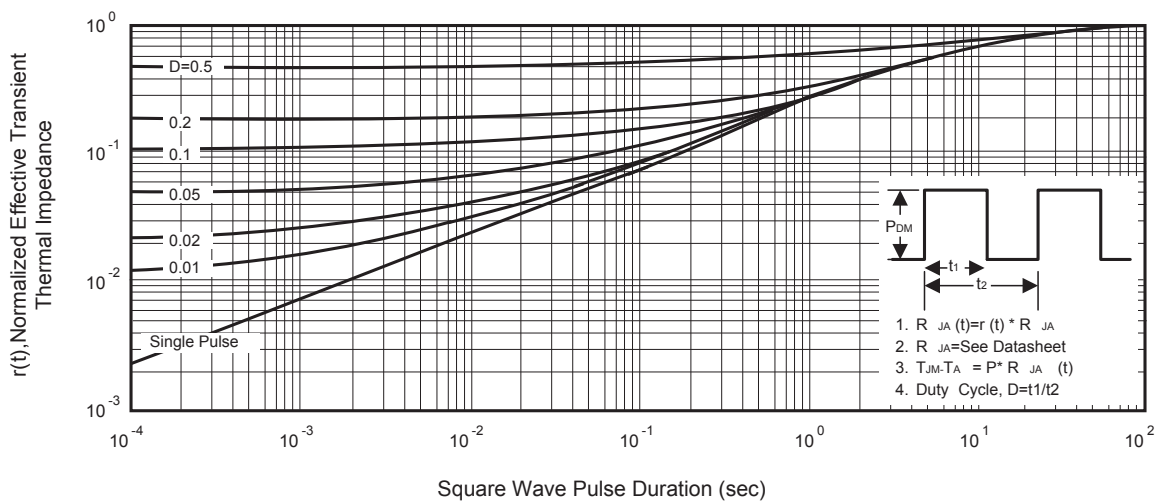
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-20	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-20V, V_{GS}=0V$	---	---	-1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.4	---	-1.0	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 10V, V_{DS}=0V$	---	---	± 25	nA
$R_{DS(on)}$	Drain-Source On-state Resistance	$V_{GS}=-4.5V, I_D=-4A$	---	39	48	m Ω
		$V_{GS}=-2.5V, I_D=-4A$	---	49	60	
gfs	Forward Transconductance	$V_{DS}=-4.5V, I_D=-4A$	7	---	---	S
Dynamic Characteristics ^⑤						
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=-10V, \text{Freq.}=1\text{MHz}$	---	751	---	pF
C_{oss}	Output Capacitance		---	115	---	
C_{rss}	Reverse Transfer Capacitance		---	80	---	
$T_{d(on)}$	Turn-on Delay Time	$V_{DS}=-10V, V_{GS}=-4.5V, R_G=3\Omega, I_D=-4A$	---	13	---	nS
T_r	Turn-on Rise Time		---	9	---	
$T_{d(off)}$	Turn-off Delay Time		---	19	---	
T_f	Turn-off Fall Time		---	29	---	
Q_g	Total Gate Charge	$V_{DS}=-10V, V_{GS}=-4.5V, I_D=-4A$	---	9.3	---	nC
Q_{gs}	Gate-Source Charge		---	1	---	
Q_{gd}	Gate-Drain Charge		---	2.2	---	
Source-Drain Characteristics ($T_J=25^\circ\text{C}$)						
V_{SD} ^④	Diode Forward Voltage	$I_S=-1A, T_J=25^\circ\text{C}$	---	-0.8	-1.2	V
t_{rr}	Reverse Recovery Time	$I_F=-4A, di/dt=100A/\mu s, T_J=25^\circ\text{C}$	---	26	---	nS
Q_{rr}	Reverse Recovery Charge		---	51	---	nC

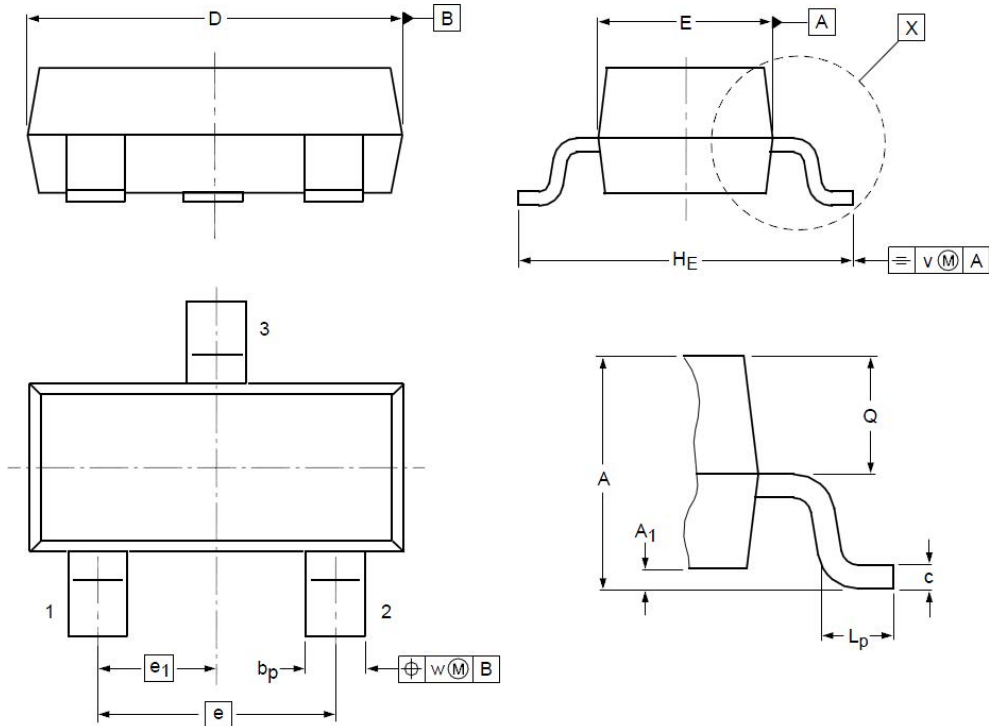
Note ④: Pulse test (pulse width 300 μs , duty cycle 2%).

Note ⑤: Guaranteed by design, not subject to production testing.

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Typical Characteristics

Figure 1. Output Characteristics

Figure 2. Transfer Characteristics

Figure 3. Capacitance

Figure 4. On-Resistance Variation with Temperature

Figure 5. Gate Threshold Variation with Temperature

Figure 6. Body Diode Forward Voltage Variation with Source Current

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Figure 7. Gate Charge

Figure 8. Maximum Safe Operating Area

Figure 9. Normalized Thermal Transient Impedance Curve

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SOT23 Package Outline Dimensions


Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	0.90	1.05	1.20	e₁	--	0.95	--
A₁	0.01	0.05	0.10	H_E	2.10	2.40	2.50
b_p	0.38	0.42	0.48	L_p	0.40	0.50	0.60
c	0.09	0.13	0.15	Q	0.45	0.49	0.55
D	2.80	2.92	3.00	V	--	0.20	--
E	1.20	1.33	1.40	W	--	0.10	--
e	--	1.90	--				